

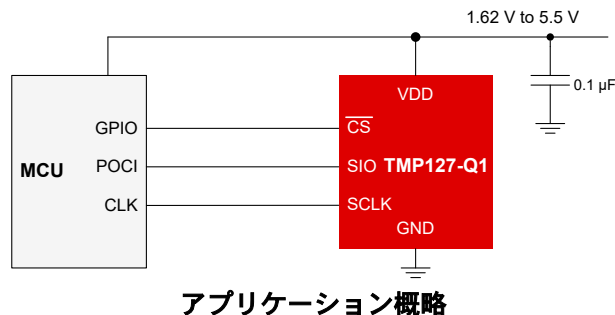
TMP127-Q1 車載用グレード、0.8°C SPI 温度センサ、175°C動作

1 特長

- 車載アプリケーション用に AEC-Q100 認定取得済み:
 - デバイス温度グレード 0: -55°C~175°Cの動作時周囲温度範囲
 - デバイス HBM 分類レベル 2
 - デバイス CDM 分類レベル C2b
- 機能安全に対応
 - 機能安全システムの設計に役立つ資料を利用可能
- 高精度
 - 55°C~150°Cで $\pm 0.8^\circ\text{C}$ 以下
 - 150°C~175°Cで $\pm 1^\circ\text{C}$ 以下
- 電源電圧範囲: 1.62V~5.5V
- 自動連続変換モード
- シャットダウン・モード
- 低い消費電力
 - スタンバイ電流: 0.5 μA (標準値)
 - シャットダウン電流: 0.35 μA (標準値)
- 出荷時に校正済み
- 3 線式 SPI インターフェイス

2 アプリケーション

- トランスミッション制御ユニット
- オンボード充電器 (OBC)
- ブレーキ・システム
- フィールド・トランスミッタ
- ビル・オートメーションとファクトリ・オートメーション
- 航空
- 超音波レベル・センシング
- 車両制御ユニット (VCU)
- パワートレイン排気ガス・センサ
- 電動パワー・ステアリング (EPS)



3 概要

TMP127-Q1 は、-55°C~175°Cの周囲温度に対応する高精度 (0.8°C) デジタル温度センサです。TMP127-Q1 は 1.62V~5.5V の電源電圧で動作する一方で、14 ビット符号付き温度分解能 (0.03125°C/LSB) を実現しています。本デバイスは優れた PSR 特性を持っており、電源電圧範囲全体にわたって精度を維持できます。変換レートが速く、消費電流が少なく、シンプルな SPI 互換インターフェイス、拡張動作温度範囲を備えているため、幅広いアプリケーションに理想的です。

TMP127-Q1 の SPI インターフェイスは、レジスタ・マップを使わない単純なプロトコル (読み取り専用の 3 線式構成、読み書き可能な 4 線式構成 (任意)) を特長としています。TMP127-Q1 は LM71 のドロップイン / ソフトウェア互換の代替品であり、熱源の近くに配置でき、また応答時間が短くなるように小型 SOT パッケージで供給されます。

デバイス情報

部品番号	パッケージ ⁽¹⁾	本体サイズ (公称)
TMP127-Q1	SOT-23 (6)	2.90mm × 1.60mm

- (1) 利用可能なパッケージについては、このデータシートの末尾にある注文情報を参照してください。

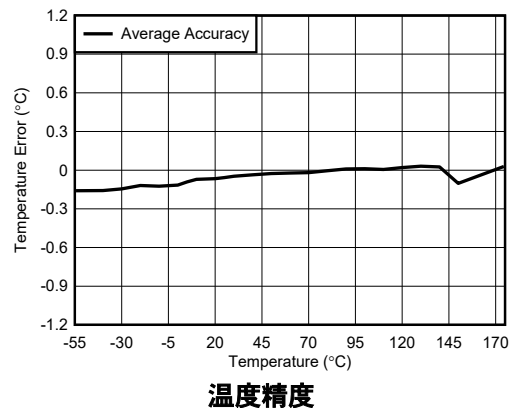


Table of Contents

1 特長	1	8.3 Feature Description.....	10
2 アプリケーション	1	8.4 Device Functional Modes.....	10
3 概要	1	8.5 Programming.....	11
4 Revision History	2	9 Application and Implementation	14
5 Device Comparison	3	9.1 Application Information.....	14
6 Pin Configuration and Functions	3	9.2 Typical Applications.....	14
7 Specifications	4	10 Power Supply Recommendations	16
7.1 Absolute Maximum Ratings.....	4	11 Layout	16
7.2 ESD Ratings.....	4	11.1 Layout Guidelines.....	16
7.3 Recommended Operating Conditions.....	4	11.2 Layout Example.....	16
7.4 Thermal Information.....	4	12 Device and Documentation Support	18
7.5 Electrical Characteristics.....	5	12.1 Receiving Notification of Documentation Updates..	18
7.6 SPI Interface Timing.....	7	12.2 サポート・リソース.....	18
7.7 Timing Diagrams.....	7	12.3 Trademarks.....	18
7.8 Typical Characteristics.....	7	12.4 Electrostatic Discharge Caution.....	18
8 Detailed Description	9	12.5 Glossary.....	18
8.1 Overview.....	9	13 Mechanical, Packaging, and Orderable Information	18
8.2 Functional Block Diagram.....	9		

4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Changes from Revision * (December 2021) to Revision A (March 2022)	Page
• データシートのステータスを事前情報から量産データに更新.....	1

5 Device Comparison

表 5-1. Device Comparison

Feature	TMP127-Q1	TMP127-Q1
Accuracy	0.25 °C	0.8 °C
Packages	DBV, DCK	DBV
Continuous and shutdown mode	•	•
175 °C operation	•	•
Grade-0	•	•
NIST Traceable	•	
Alert pin functionality	•	
Slew rate warning	•	
CRC option	•	

6 Pin Configuration and Functions

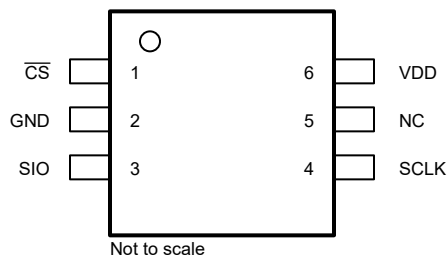


图 6-1. DBV 6-Pin SOT-23 (Top View)

表 6-1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	NO.		
CS	1	I	Active low chip select signal to activate SPI interface
GND	2	–	Ground
SIO	3	I/O	Peripheral input/output
SCLK	4	I	Peripheral clock input
NC	5	NC	No Connect. Must be left floating or grounded.
VDD	6	–	Supply voltage

7 Specifications

7.1 Absolute Maximum Ratings

Over free-air temperature range unless otherwise noted⁽¹⁾

		MIN	MAX	UNIT
Supply voltage	VDD	-0.3	6	V
I/O voltage	SIO	-0.3	$V_{DD} + 0.2$	V
I/O voltage	CS, SCLK	-0.3	6	V
Operating junction temperature, T_J		-65	180	°C
Storage temperature, T_{stg}		-65	180	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 HBM classification level 2	±2000	V
		Charged-device model (CDM), per AEC Q100-011 CDM classification level C2b	±750	V

7.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{DD}	Supply voltage	1.62	3.3	5.5	V
$V_{I/O}$	SIO	0		V_{DD}	V
$V_{I/O}$	CS, SCLK	0		5.5	V
T_A	Operating ambient temperature ⁽¹⁾	-55		175	°C

- (1) HTOL was performed at 175 °C for 1410 hours

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TMP127-Q1	UNIT
		DBV (SOT-23)	
		6 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	168.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	85.5	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	–	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	48.1	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	27.5	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	47.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

7.5 Electrical Characteristics

Over free-air temperature range and $V_{DD} = 1.62\text{ V}$ to 5.5 V (unless otherwise noted); Typical specifications are at $T_A = 25\text{ }^{\circ}\text{C}$ and $V_{DD} = 3.3\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TEMPERATURE SENSOR						
T_{ERR}	Temperature accuracy	-55 °C to 150 °C	-0.8		0.8	°C
	Temperature accuracy	150 °C to 175 °C	-1		1	°C
PSR	DC power supply rejection			12.7		m°C/V
T_{RES}	Temperature resolution	Including sign bit		14		Bits
		LSB		31.25		m°C
T_{REPEAT}	Repeatability ⁽¹⁾	$V_{DD} = 3.3\text{ V}$		±1		LSB
T_{LTD}	Long-term stability and drift ⁽²⁾	1000 hours at 175 °C		0.07		°C
	Temperature cycling and hysteresis ⁽³⁾			±0.5		LSB
t_{CONV_PERIOD}	Conversion Period			200	270	ms
t_{CONV}	Active conversion time		4.5	6	7.5	ms
DIGITAL INPUT/OUTPUT						
C_{IN}	Input capacitance	$f = 1\text{ MHz}$			20	pF
V_{IH}	Input logic high level	SCLK, SIO, $\overline{CS}$	$0.7 * V_{DD}$		V_{DD}	V
V_{IL}	Input logic low level	SCLK, SIO, $\overline{CS}$	0	$0.3 * V_{DD}$		V
I_{IN}	Input leakage current	SCLK, SIO, $\overline{CS}$	-0.5		0.5	µA
V_{OH}	SIO output high level	$I_{OH} = 3\text{ mA}$	$V_{DD} - 0.4$		V_{DD}	V
V_{OL}	SIO output low level	$I_{OL} = -3\text{ mA}$	0		0.4	V

TMP127-Q1

JAJSK89A – DECEMBER 2021 – REVISED MARCH 2022

Over free-air temperature range and $V_{DD} = 1.62\text{ V}$ to 5.5 V (unless otherwise noted); Typical specifications are at $T_A = 25\text{ }^{\circ}\text{C}$ and $V_{DD} = 3.3\text{ V}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
POWER SUPPLY							
I _{DD_ACTIVE}	Supply current during active conversion	$\overline{CS} = V_{DD}$	T _A = 25 °C		77	87	μA
			T _A = -55 °C to 150 °C			135	
			T _A = 175 °C			160	
I _{DD}	Average current consumption	$\overline{CS} = V_{DD}$	T _A = 25 °C		2.65	4	μA
			T _A = -55 °C to 150 °C			19	
			T _A = 175 °C			38	
I _{SB}	Standby current ⁽⁴⁾	$\overline{CS} = V_{DD}$	T _A = 25 °C		0.5	0.75	μA
			T _A = -55 °C to 150 °C			15	
			T _A = -55 °C to 175 °C			34	
I _{SD}	Shutdown current	$\overline{CS} = V_{DD}$	T _A = 25 °C		0.35	0.5	μA
			T _A = -55 °C to 150 °C			15	
			T _A = -55 °C to 175 °C			34	
V _{POR}	Power-on reset threshold voltage	Supply rising			1.3		V
	Brownout detect	Supply falling			1.1		V
t _{RESET}	Reset Time	Time required by device to reset			0.5		ms

- (1) Repeatability is the ability to reproduce a reading when the measured temperature is applied consecutively, under the same conditions.
- (2) Long term stability is determined using accelerated operational life testing at a junction temperature of $150\text{ }^{\circ}\text{C}$.
- (3) Hysteresis is defined as the ability to reproduce a temperature reading as the temperature varies from room $\rightarrow$ hot $\rightarrow$ room $\rightarrow$ cold $\rightarrow$ room. The temperatures used for this test are $-40\text{ }^{\circ}\text{C}$, $25\text{ }^{\circ}\text{C}$, and $150\text{ }^{\circ}\text{C}$.
- (4) Quiescent current between conversions

7.6 SPI Interface Timing

Over free-air temperature range and $V_{DD} = 1.62\text{ V}$ to 5.5 V (unless otherwise noted)

		SPI BUS		UNIT
		MIN	MAX	
f_{CLK}	SCLK frequency		10	MHz
t_{CLK}	SCLK Period	100		ns
t_{LEAD}	Falling edge of $\overline{CS}$ to rising edge of SCLK setup time	100		ns
t_{LAG}	Rising edge of SCLK to rising edge of $\overline{CS}$ setup time	20		ns
t_{SU}	SIO to SCLK rising edge setup time	10		ns
t_{HOLD}	SIO hold time after rising edge of SCLK	20		ns
t_{VALID}	Time from falling edge of SCLK to valid SIO data		35	ns
$t_{SIO(DIS)}$	Time from rising edge of $\overline{CS}$ to SIO high-impedance		200	ns
$t_{SIO(EN)}$	Time from falling edge of $\overline{CS}$ to SIO low impedance		70	ns
t_{RISE}	SIO, SCLK, $\overline{CS}$ rise time		100	ns
t_{FALL}	SIO, SCLK, $\overline{CS}$ fall time		100	ns
$t_{INTERFRAME}$	Delay between two SPI communication sequences ($\overline{CS}$ high)	100		ns
$t_{INITIATION}$	Delay between valid V_{DD} voltage and initial SPI communication	0.5		ms

7.7 Timing Diagrams

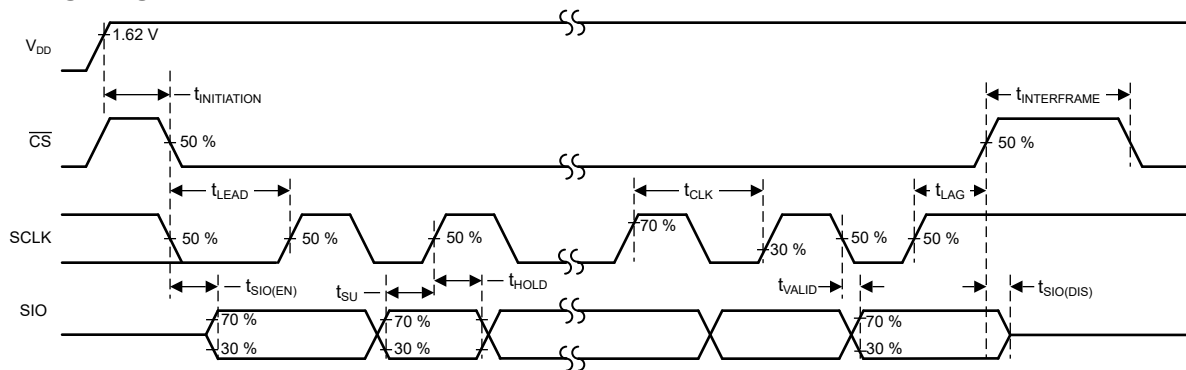


FIG 7-1. SPI Interface Timing Diagram

7.8 Typical Characteristics

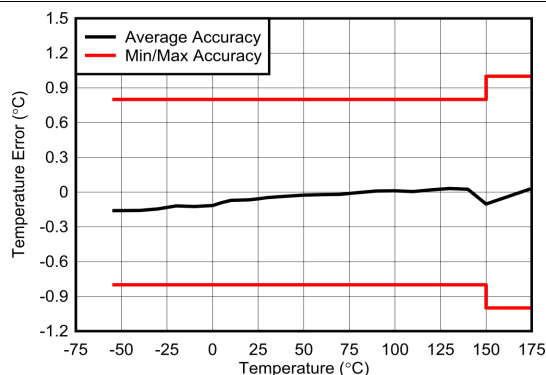


FIG 7-2. Temperature Accuracy

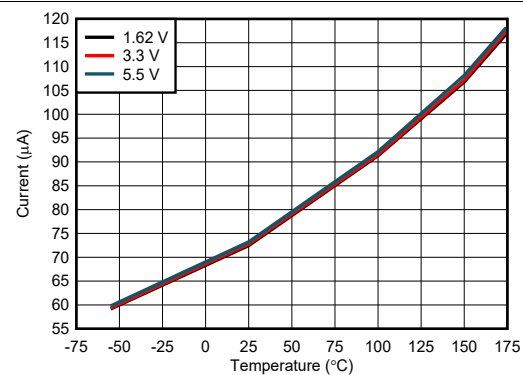


FIG 7-3. Active Conversion Current vs. Temperature

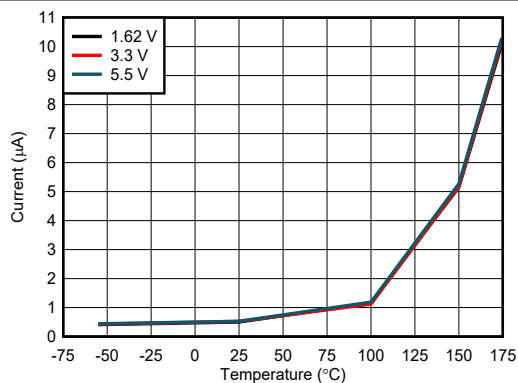


Figure 7-4. Standby Current vs. Temperature

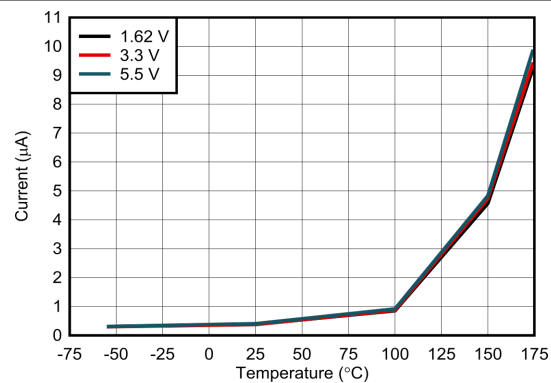


Figure 7-5. Shutdown Current vs. Temperature

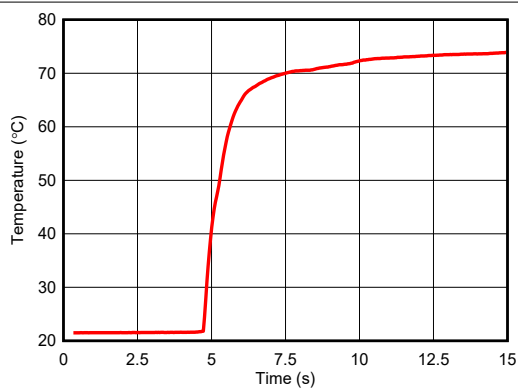


Figure 7-6. Stirred Liquid Single Layer Response Time (DBV)

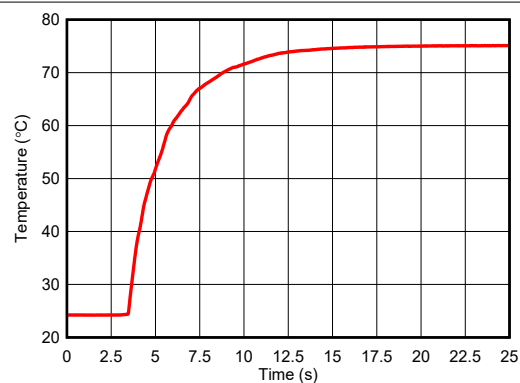


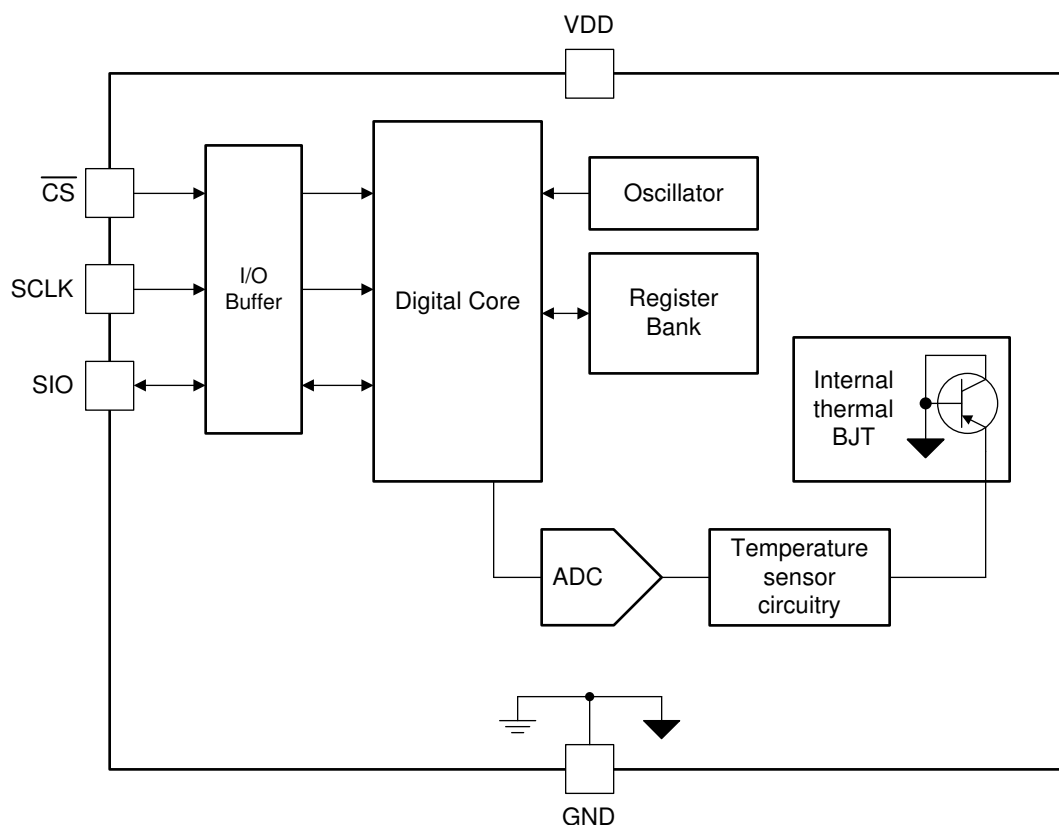
Figure 7-7. Stirred Liquid 2-Layer Response Time (DBV)

8 Detailed Description

8.1 Overview

The TMP127-Q1 is a factory-calibrated digital output temperature sensor designed for thermal management and thermal protection applications. The TMP127-Q1 has a 3-wire SPI-compatible interface with continuous conversion and shutdown modes. The shutdown mode can be used to optimize current consumption for low power applications.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Low Power Consumption

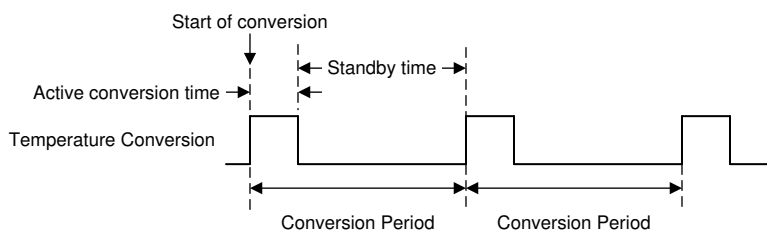
The TMP127-Q1 features a power optimized conversion period with minimized conversion time to reduce system power consumption. By minimizing the conversion time, the TMP127-Q1 operates mainly in the low-power, standby portion of the conversion period. This feature is designed for low-power or battery applications that operate in continuous conversion mode. The device also features a further power reduced shutdown mode for greater power savings.

8.4 Device Functional Modes

The TMP127-Q1 has two operation modes: continuous conversion mode and shutdown mode.

8.4.1 Continuous Conversion Mode

The TMP127-Q1 always powers up in the continuous conversion mode. Immediately after power up, the TMP127-Q1 temperature register will contain an erroneous code until the first temperature conversion has completed. In the continuous conversion mode, the TMP127-Q1 will run a temperature conversion every 200 ms. To enter continuous conversion mode from the shutdown mode, the user must write XX00h to the configuration register. If user writes XX00h to the configuration register, the continuous conversion mode will repeatedly run and the device will continue the conversion period uninterrupted. Repeatedly reading and writing to the TMP127-Q1 will not cause adverse behavior. The temperature register output will update to the latest conversion results when $\overline{CS}$ is pulled low to start a temperature read.



8-1. Conversion Period Timing Diagram

8.4.2 Shutdown Mode

If the user writes XXFFh to the configuration register, the device will enter shutdown mode. In shutdown mode, the serial bus is still active and the TMP127-Q1 will always output the device ID, 900Fh. If the TMP127-Q1 is performing a temperature conversion, the device will stop the temperature conversion and discard the data to enter shutdown mode immediately.

8.5 Programming

8.5.1 Temperature Data Format

Temperature data is represented by a 14-bit, two's complement word with an LSB (Least Significant Bit) equal to 0.03125 °C. The last two bits of the register are always 11b.

表 8-1. 14-Bit Temperature Data Format

Temperature	Digital Output	
	Binary	Hex
175 °C	0101 0111 1000 0011	5783
150 °C	0100 1011 0000 0011	4B03
125 °C	0011 1110 1000 0011	3E83
25 °C	0000 1100 1000 0011	0C83
0.03125 °C	0000 0000 0000 0111	0007
0 °C	0000 0000 0000 0011	0003
-0.03125 °C	1111 1111 1111 1111	FFFF
-25 °C	1111 0011 1000 0011	F383
-40 °C	1110 1100 0000 0011	EC03
-55 °C	1110 0001 0000 0011	E483

The first data byte is the Most Significant Byte (MSB) with most significant bit first, permitting only as much data as necessary that must be read to determine temperature condition. For example, if the first four bits of the temperature data indicate an overtemperature condition, the host controller could immediately take action to remedy the excessive temperatures.

8.5.2 Serial Bus Interface

The TMP127-Q1 operates as a peripheral and is compatible with SPI or MICROWIRE bus specifications. Data is clocked out on the falling edge of the serial clock (SCLK), while data is clocked in on the rising edge of SCLK. A complete transmit/receive communication will consist of 32 serial clocks. The first 16 clocks comprise the transmit phase of communication from the Device ID or Temperature Register, while the second 16 clocks are the receive phase to the Configuration Register. There is no issue using 8-bit SPI with the 16-bit interface as long as the $\overline{CS}$ remains low during the transaction. Mode transitions through writes to the configuration register will occur on the 16th rising clock edge during the 16-bit write.

Two modes of SPI communication are supported:

- Mode 0:
 - CPOL = 0
 - CPHA = 0
- Mode 3:
 - CPOL = 1
 - CPHA = 1

When $\overline{CS}$ is high, SIO will be in low-impedance tri-state. The user should take the chip select ($\overline{CS}$) low to initiate communication. This should not be done when SCLK is changing from a low to high state. When $\overline{CS}$ is low, the serial I/O pin (SIO) will transmit the first bit of data. The controller can then read this bit with the rising edge of SCLK. The remainder of the data will be clocked out by the falling edge of SCLK. $\overline{CS}$ can be taken high at any time during the transmit phase. If $\overline{CS}$ is brought low in the middle of a conversion, the TMP127-Q1 will complete the conversion and the output shift register will be updated after $\overline{CS}$ is brought back high.

The receive phase of a communication starts after 16 SCLK periods. $\overline{CS}$ can remain low as long as required. After 32 SCLK rising edges, the TMP127-Q1 will take control of the SIO pin and be ready for another read/write cycle. The TMP127-Q1 will read the data available on the SIO line on the rising edge of the serial clock. The last 8 bits of the configuration register are the Mode[7:0] bits and place the device into shutdown or continuous conversion mode. The receive phase can last up to 16 SCLK periods. Only the following operation codes will affect the TMP127-Q1 and any other codes placed into the Mode[7:0] field will be ignored

- 00 hex for continuous conversion
- FF hex for shutdown

Figure 8-2 shows an overview of the communication protocol.

-  Controller controls SIO line
-  Peripheral controls SIO line

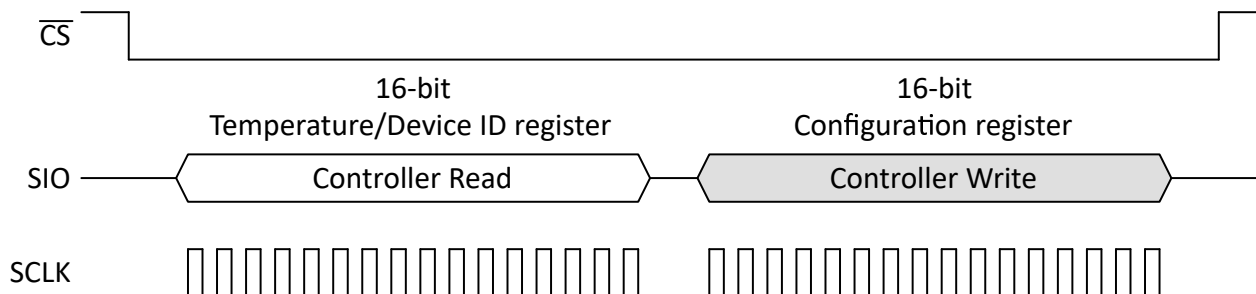


Figure 8-2. TMP127-Q1 Communication overview

After start-up or upon entering continuous mode, 200 ms must pass for a conversion to complete before the TMP127-Q1 transmits accurate temperature data.

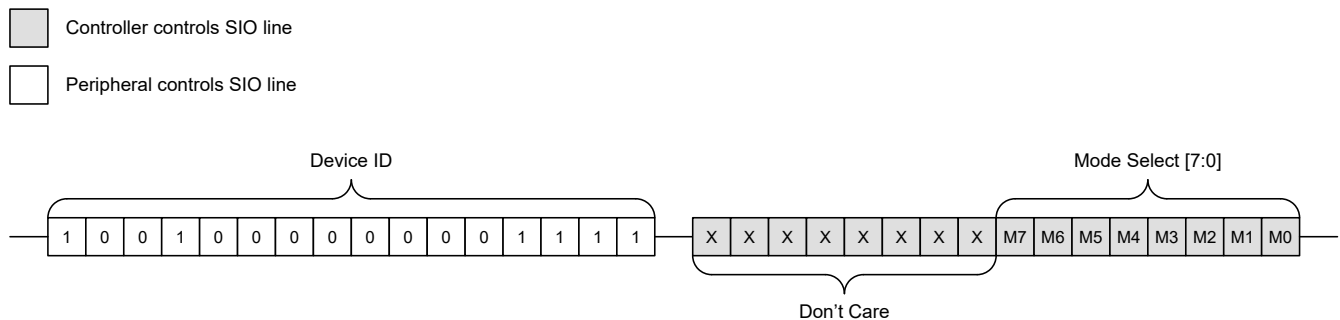
The following communication can be used to determine the Manufacturer's/Device ID and then immediately place the part into continuous conversion mode. With $\overline{CS}$ continuously low:

- Read 16 bits of temperature data
- Write 16 bits of data commanding Shutdown Mode(00FFh)
- Read 16 bits of Manufacture's/Device ID data
- Write 16 bits of data commanding Continuous Conversion Mode (0000h)
- Take $\overline{CS}$ HIGH.

8.5.2.1 Communication in Shutdown Mode

Shutdown mode is enabled by writing XXFFh to the Mode byte in the configuration register. While in shutdown mode, the TMP127-Q1 will output the device ID information on the SIO pin for the first 16 clock cycles. After the 16th rising SCLK edge, the TMP127-Q1 will tri-state the SIO pin and be ready for the controller to write to the configuration register.

✕ 8-3 shows a diagram of the communication in shutdown mode.

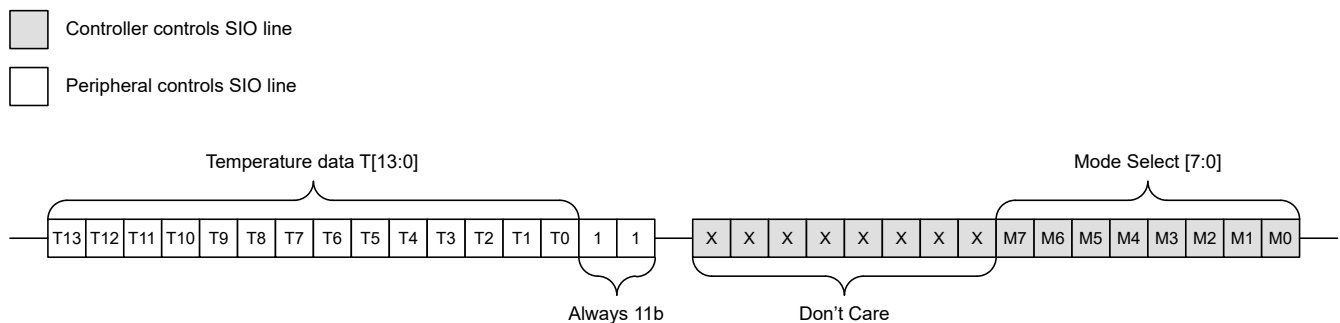


✕ 8-3. Shutdown Mode SPI Communication

8.5.2.2 Communication in Continuous Conversion Mode

Continuous Conversion mode is enabled by writing XX00h to the Mode byte in the configuration register. While in continuous conversion mode, the TMP127-Q1 will output the latest Temperature information on the SIO pin for the first 16 clock cycles. After the 16th falling SCLK edge, the TMP127-Q1 will tri-state the SIO pin and be ready for the Controller to drive the SIO pin to write to the configuration register.

✕ 8-3 shows a diagram of the communication in continuous conversion mode.



✕ 8-4. Continuous Conversion Mode SPI Communication

8.5.2.3 Internal Register Structure

The TMP127-Q1 has three registers that can be accessed depending on the operating mode of the device. The temperature register is accessible in the continuous conversion mode and is read-only. The device ID register is accessible in the shutdown mode and is read-only. The configuration register is accessible in either shutdown or continuous mode and is write-only.

9 Application and Implementation

Note

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくことになります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

9.1 Application Information

The TMP127-Q1 operate in 2 different configurations to fit the system requirements: a standard read/write configuration or a read-only configuration.

9.2 Typical Applications

9.2.1 Read-Only Configuration

The TMP127-Q1 can operate in a read-only configuration when the host only needs to read the temperature data without changing the mode of device operation. In this configuration, the host does not need to connect the PICO pin to the SIO pin of the TMP127-Q1. Only the POCI pin is connected to SIO for read only operations.

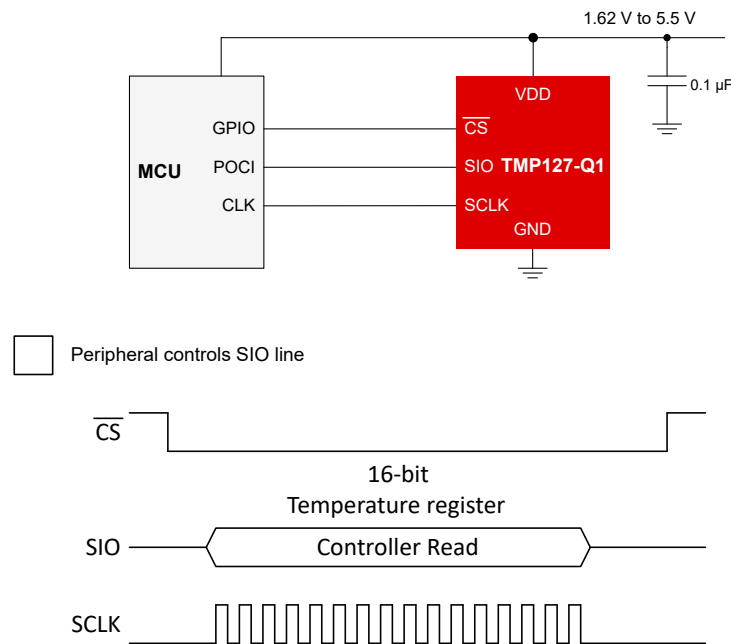


Figure 9-1. Read-Only Configuration

9.2.1.1 Design Requirements

For this design example, use the parameters listed below.

PARAMETER	Value
Supply (V _{DD})	1.62 V to 5.5 V

9.2.1.2 Detailed Design Procedure

The TMP127-Q1 will convert temperature at a 200-ms interval with a maximum conversion period of 270 ms per the [Electrical Characteristics](#) table. Reading from the TMP127-Q1 faster than the conversion period can result in data being retrieved twice before new data is available. Therefore TI recommends to read from the TMP127-Q1 in intervals greater than the maximum conversion period (like every 300 ms, for example). Reading faster than the conversion period will not disrupt device operation and can safely be done if desired.

In the read-only configuration, the TMP127-Q1 is not connected to a controller PICO pin. Due to this if the SCLK pin were to continue to be clocked for the write portion of the transaction, the SIO pin would be floating and the write value undetermined. It is for this reason that TI recommends to only perform the first 16 clock cycles to read the TMP127-Q1 temperature date and pull $\overline{CS}$ high after, as shown in [Figure 9-1](#). This will ensure the TMP127-Q1 is never written to with a floating input.

9.2.2 Read/Write Configuration

The TMP127-Q1 can operate in a read/write configuration when the controller must both read and write to the TMP127-Q1.

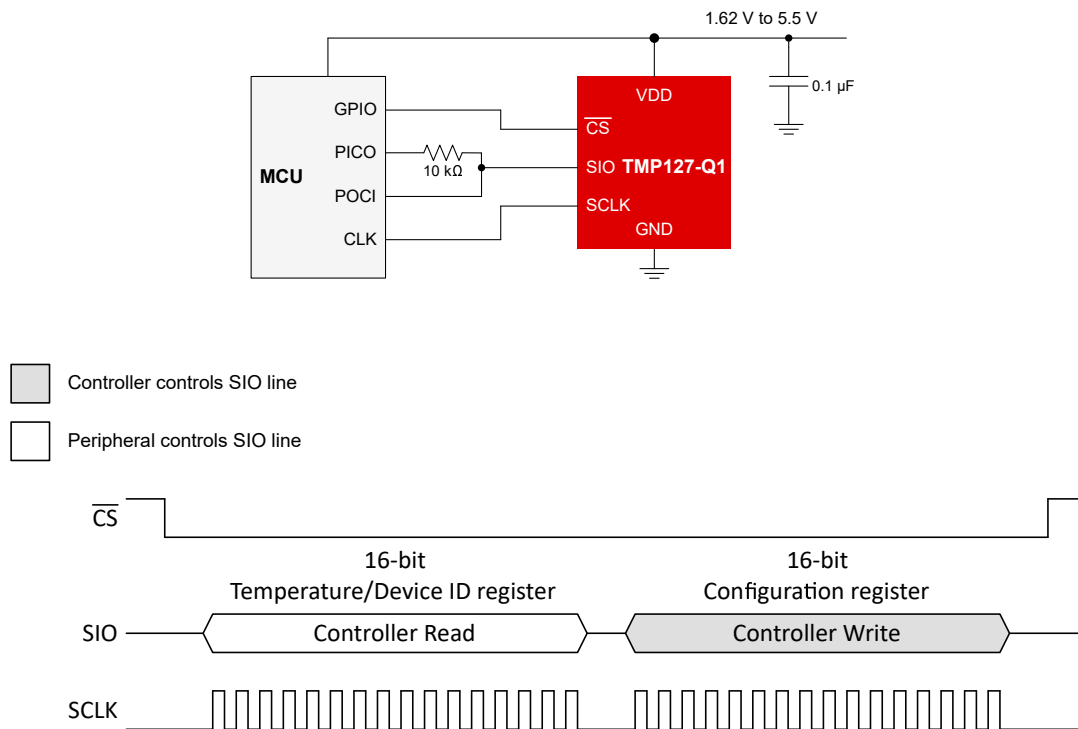


Figure 9-2. 4-Wire Configuration

9.2.2.1 Design Requirements

For this design example, use the parameters listed below.

PARAMETER	Value
Supply (V_{DD})	1.62 V to 5.5 V
Isolation Resistor	10 k Ω

9.2.2.2 Detailed Design Procedure

In this configuration, an isolation resistor is used between the PICO pin of the controller and the SIO pin of the TMP127-Q1 to prevent bus contention. Being able to write to the TMP127-Q1 will allow the system to use the shutdown mode and read the device ID.

10 Power Supply Recommendations

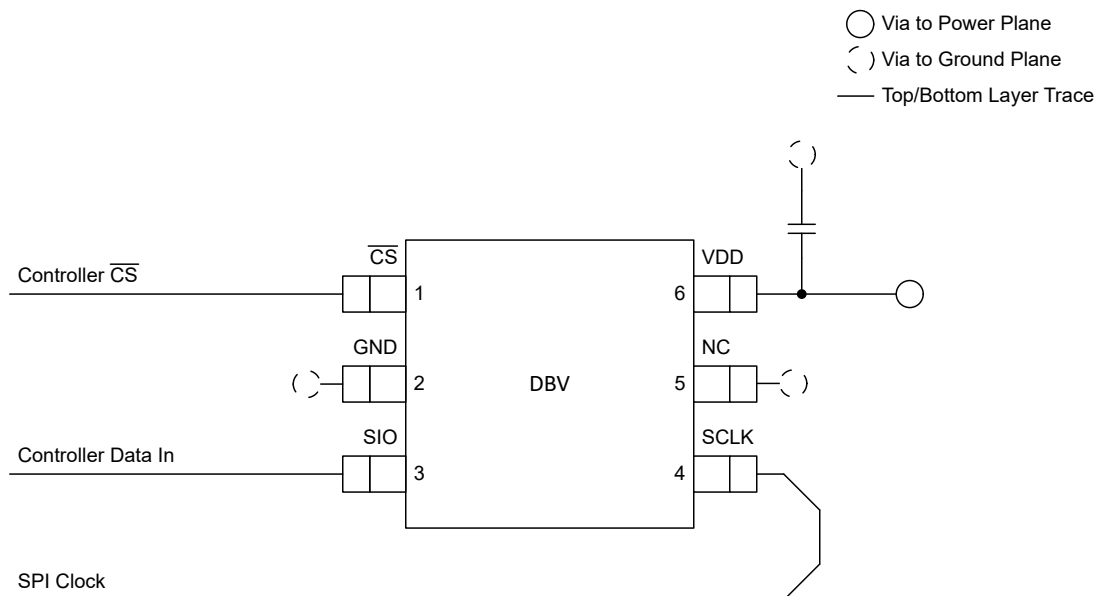
The TMP127-Q1 operates from a single supply VDD. This pin operates with a wide range of 1.62 V to 5.5 V and maintains accuracy across the entire supply range. A decoupling capacitor of 0.1 μ F is recommended for the VDD pin. Place the capacitor as close to the pin as possible.

11 Layout

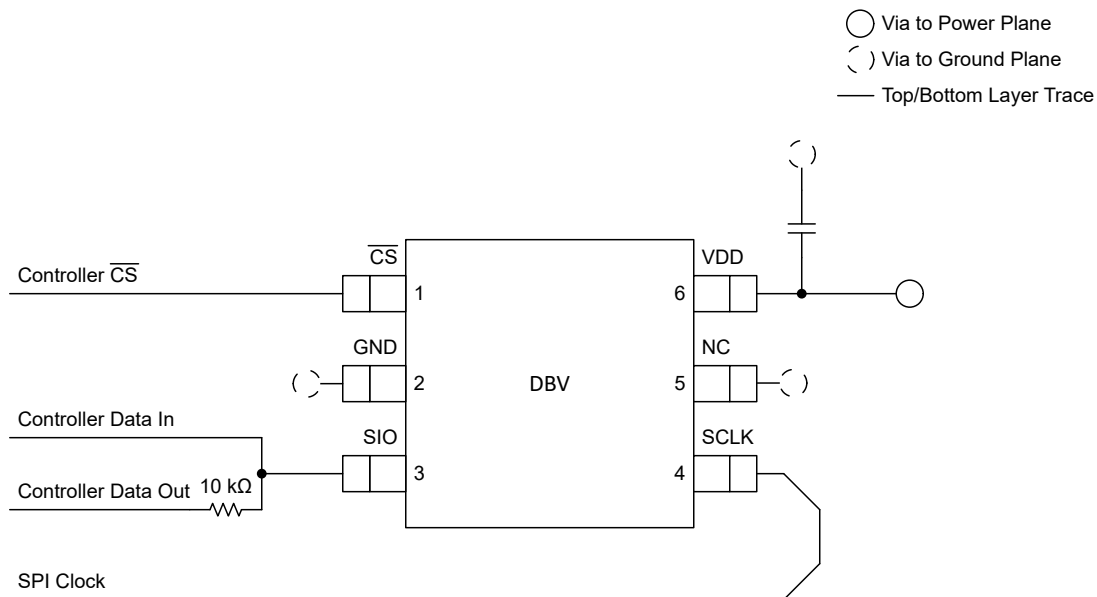
11.1 Layout Guidelines

Place the power-supply decoupling capacitor as close to the supply and ground pins as possible. The recommended value of this decoupling capacitor is 0.1 μ F. Separation between the SCLK trace and the SI/O traces is recommended to reduce coupling of the clock onto the data line.

11.2 Layout Example



11-1. Read-Only Configuration Layout Example



11-2. Read/Write Configuration Layout Example

12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](https://www.ti.com). Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

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12.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TMP127EDBVRQ1	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 175	2NGA
TMP127EDBVRQ1.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 175	2NGA

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMP127EDBVRQ1	SOT-23	DBV	6	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMP127EDBVRQ1	SOT-23	DBV	6	3000	190.0	190.0	30.0



SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



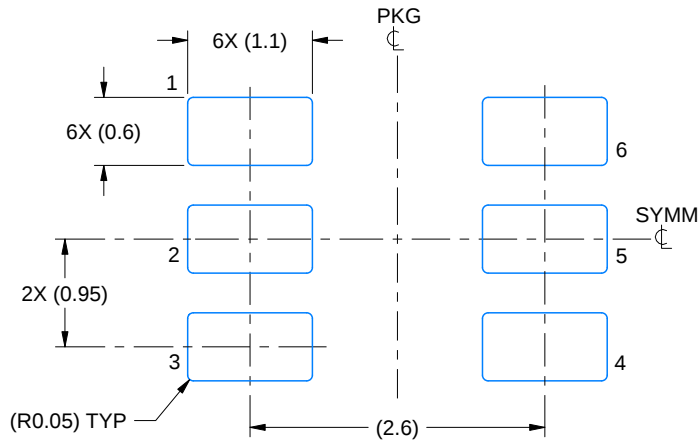
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.
4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
5. Reference JEDEC MO-178.

EXAMPLE BOARD LAYOUT

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

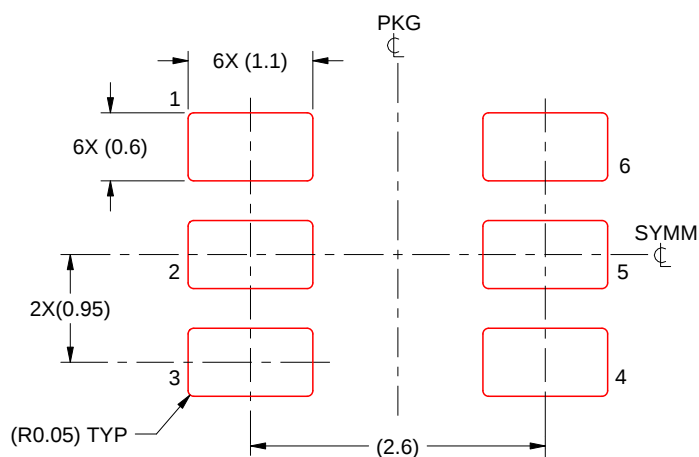
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0006A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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